

Notice of References Cited	Application/Control No. 10/798,469	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,665,209 B2	12-2003	Osada et al.	365/154
*	B	US-6,542,428 B2	04-2003	Hidaka, Hideto	365/230.03
*	C	US-6,418,067 B1	07-2002	Watanabe et al.	365/200
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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